

ON Semiconductor®

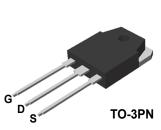
FQA10N80C-F109 N-Channel QFET[®] MOSFET 800 V, 10 A, 1.1 Ω

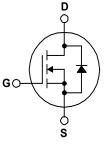
Features

- + 10 A, 800 V, $R_{DS(on)}$ = 1.1 Ω (Max.) @ V_{GS} = 10 V, I_D = 5 A
- Low Gate Charge (Typ. 44 nC)
- Low Crss (Typ. 15 pF)
- 100% Avalanche Tested
- RoHS compliant

Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter Drain to Source Voltage			FQA10N80C-F109	Unit
V _{DSS}				800	V
I _D	Drain Current	-Continuous (T _C = 25 ^o C)		10	А
	Drain Current	-Continuous (T _C = 100 ^o C)		6.32	А
I _{DM}	Drain Current	- Pulsed	(Note 1)	40	А
V _{GSS}	Gate to Source Voltage			± 30	V
E _{AS}	Single Pulsed Avalanch	e Energy	(Note 2)	920	mJ
I _{AR}	Avalanche Current		(Note 1)	10	A
E _{AR}	Repetitive Avalanche Er	nergy	(Note 1)	24	mJ
dv/dt	Peak Diode Recovery d	v/dt	(Note 3)	4.0	V/ns
P _D	Dower Dissinction	(T _C = 25°C)		240	W
	Power Dissipation	- Derate above 25 ^o C		1.92	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter	FQA10N80C-F109	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max	0.52	°C/W	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max	40	°C/W	

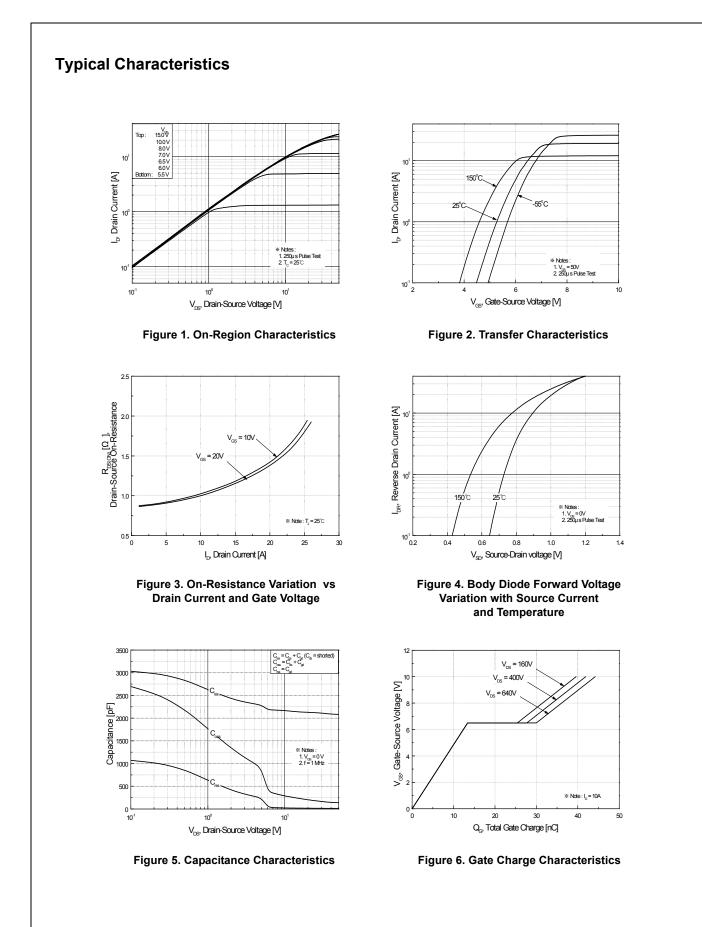
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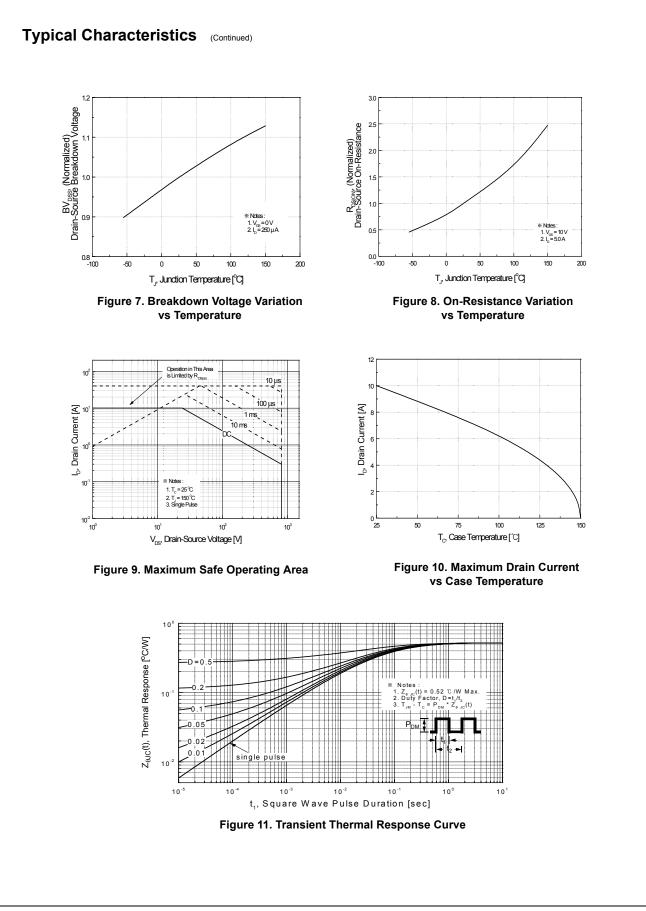
Part Number Top Mar		Top Mark	Package	Packing Method	Reel Size	e	Tape Widt	h Q	uantity
FQA10N			TO-3PN					30 units	
lectric	cal Char	acteristics T _C = 25°	C unless otl	nerwise noted.					
Symbol	Parameter			Test Conditions		Min	Тур	Max	Unit
Off Cha	racteristi	CS .							
BV _{DSS}	Drain-Source Breakdown Voltage		V _{GS} = 0	V _{GS} = 0 V, I _D = 250 μA					V
ΔBV _{DSS} / ΔT _J	Breakdown Coefficient	Voltage Temperature	$I_D = 250 \ \mu$ A, Referenced to 25° C			0.98		V/°C	
1	Zoro Coto V	Zerra Octo Malle na Davia Orana at		V _{DS} = 800 V, V _{GS} = 0 V				10	μA
IDSS		Voltage Drain Current	V _{DS} = 640 V, T _C = 125°C					100	μA
I _{GSSF}	Gate-Body	Leakage Current, Forward		V _{GS} = 30 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body	Leakage Current, Reverse	se V _{GS} = -30 V, V _{DS} = 0 V					-100	nA
On Cha	racteristic	cs							
V _{GS(th)}		Sate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$			3.0		5.0	V	
R _{DS(on)}	Statia Drain Source			V_{GS} = 10 V, I _D = 5.0 A			0.93	1.1	Ω
9 _{FS}	Forward Tra	prward Transconductance $V_{DS} = 50 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$				5.8		S	
-	c Charact	eristics	-						1
C _{iss}	Input Capa		V _{DS} = 25 V, V _{GS} = 0 V,			2150	2800	pF	
C _{oss}	Output Capacitance		f = 1.0 M	f = 1.0 MHz			180	230	pF
C _{rss}	Reverse Tr	ansfer Capacitance					15	20	pF
Switchi	ng Chara	cteristics							
t _{d(on)}	Turn-On De	Turn-On Delay Time		0 V In = 10 0 A			50	110	ns
t _r	Turn-On Ri	se Time		$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 10.0 \text{ A},$ R _G = 25 Ω			130	270	ns
t _{d(off)}	Turn-Off De	elay Time	0				90	190	ns
t _f	Turn-Off Fa	III Time			(Note4)		80	170	ns
Qg	Total Gate	Charge	V _{DS} = 64	0 V, I _D = 10.0 A,			45	58	nC
Q _{gs}	Gate-Sourc	e Charge	V _{GS} = 10	V			13.5		nC
Q _{gd}	Gate-Drain	Charge		(Note 4)			17		nC
		de Chevesteristice e		num Detinne					
Is		ode Characteristics a Continuous Drain-Source D						10.0	А
I _{SM}		Pulsed Drain-Source Diode					40.0	A	
V _{SD}		ce Diode Forward Voltage	$V_{GS} = 0 V, I_S = 10.0 A$					1.4	V
t _{rr}		ecovery Time		V, I _S = 10.0 A,			730		ns
		- , -	$dl_{\rm F}$ / dt = 100 A/µs						

2. L = 17.3 mH, I_{AS} = 10 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C.

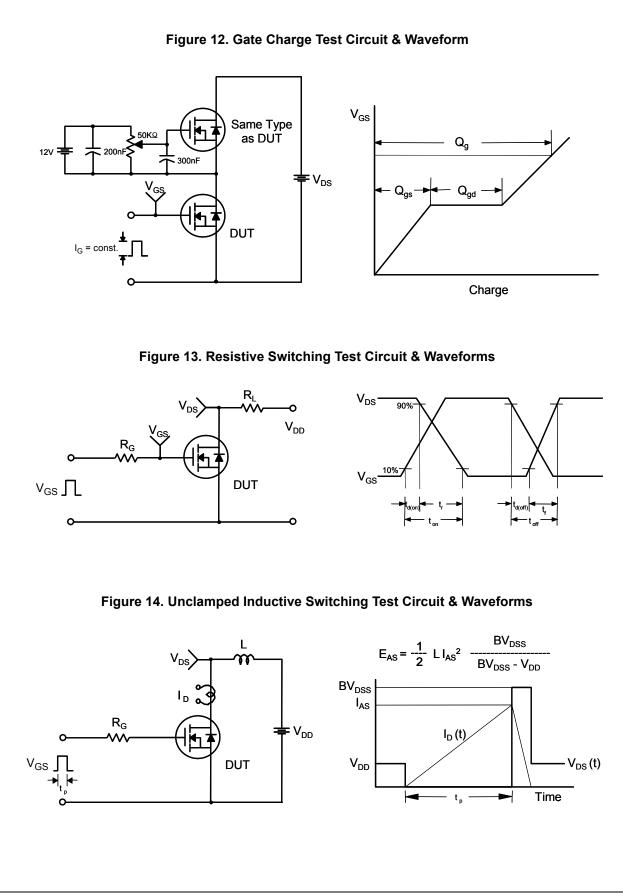
3. I_{SD} \leq 8.4 A, di/dt \leq 200 A/µs, V_{DD} \leq BV_{DSS,} starting ~ T_J = 25°C.

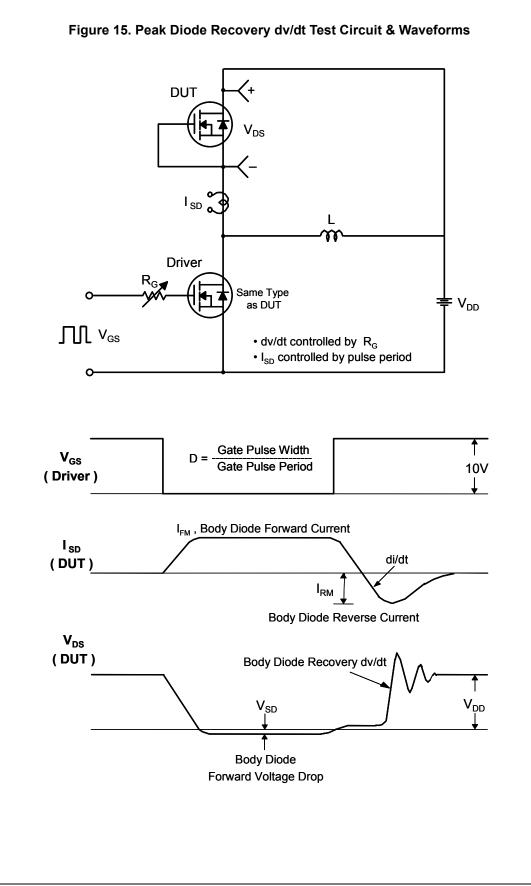
4. Essentially independent of operating temperature.

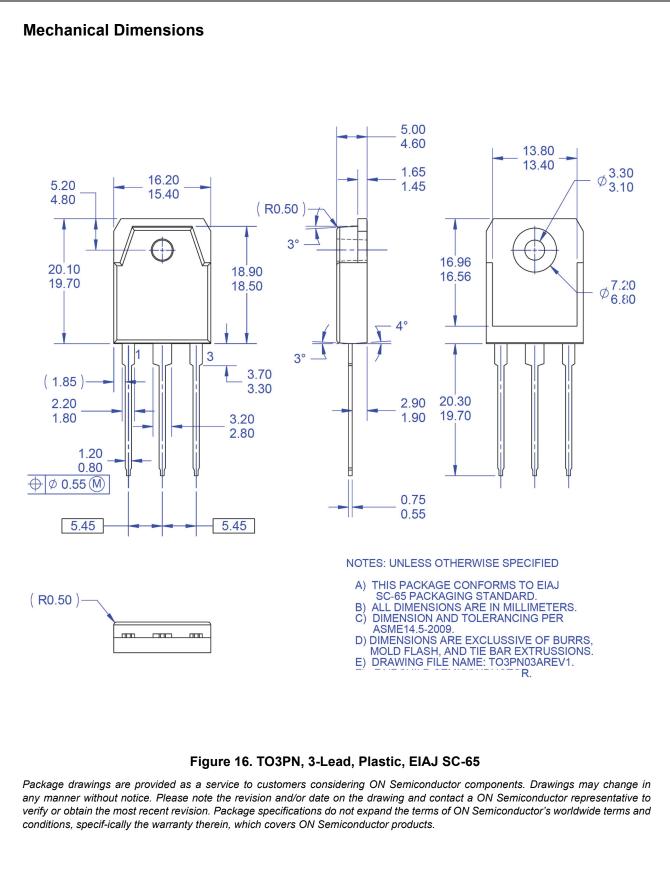




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